



PTO/SB/08A (10-01)

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<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (use as many sheets as necessary)		<b>Complete if Known</b>	
		Application Number	10/024,506
		Filing Date	12-28-2001
		First Named Inventor	Strohben, et al
		Art Unit	
		Examiner Name	
Sheet <u>1</u>	of <u>3</u>	Attorney Docket Number	P-4899

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U.S. PATENT DOCUMENTS					
Examiner Initials <sup>*</sup>	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number - Kind Code <sup>2</sup> (if known)			
M N		US- 6091975	07-18-2000	DADDONA, et al.	
		US- 6036924	03-14-2000	SIMONS, et al.	
		US- 2001003045	06-07-2001	DAVIS, et al.	
		US- 6275717	08-14-2001	GROSS, et al.	
		US- 5914026	06-22-1999	BLUBAUGH, et al.	
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		US-			
		US- 5660163	08-26-1997	SCHULMAN, et al.	
		US- 5820622	10-13-1998	GROSS, et al.	
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		US- 5510266	04-23-1996	BONNER, et al.	
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		US- 5445920	08-29-1995	SAITO	
		US- 5680858	10-28-1997	HANSEN, et al.	
		US- 5165407	11-24-1992	WILSON, et al.	
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		US- 4953552	09-04-1990	DEMARZO	
		US- 4970145	11-13-1990	BENNETTO, et al.	
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		US-			

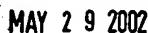
FOREIGN PATENT DOCUMENTS							
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>6</sup>
		Country Code <sup>3</sup>	-Number <sup>4</sup> - Kind Code <sup>5</sup> (if known)				
M    N		WO	0010007	02-24-2000	ARNOLD, et al.		
		WO	01013102	02-22-2001	VADGAMA		
		EP	320109	06-14-1989	BECK, et al.		
		WO	9932174	01-07-1999	CHO, et al.		
		EP	264210	10-02-1987	REIMER		

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Substitute for form 1449B/PTO		<b>Complete if Known</b>	
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		Examiner Name	
Sheet	3	of	3
		Attorney Docket Number	P-4899

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OTHER PRIOR ART -- NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T <sup>2</sup>
m		BUCK, R. P.; COSOFRET, V. V.; LINDNER, E.; UFER, S.; MADARAS, M. B.; JOHNSON, T. A.; ASH, R. B., AND NEUMAN, M. R. Microfabrication Technology of Flexible Membrane-Based Sensors for in-Vivo Applications. <i>Electroanalysis</i> . 1995 Sep; 7(9):846-851.	
		JUNG, S. K.; GORSKI, W.; ASPINWALL, C. A.; KAURI, L. M., AND KENNEDY, R. T. Oxygen Microsensor and Its Application to Single Cells and Mouse Pancreatic Islets. <i>Analytical Chemistry</i> . 1999 Sep 1; 71(17):3642-3649	
		CHEN, C Y; TAMIYA, E; ISHIHARA, K; KOSUGI, Y; SU, Y C; NAKABAYASHI, N, AND KARUBE, I. A Biocompatible Needle-Type Glucose Sensor Based On Platinum-Electroplated Carbon Electrode. <i>Applied Biochemistry and Biotechnology</i> . 1992 Sep; 36(3):211-226	
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		YANG, QINGLING; ATANASOV, PLAMEN, AND WILKINS, EBTISAM. Development Of Needle-Type Glucose Sensor With High Selectivity. <i>Sensors and Actuators B: Chemical</i> . 1998 May 15; 46(3):249-256	
		ZEN, J. M.; KUMAR, A. S., AND WANG, H. F. A Dual Electrochemical Sensor for Nitrite and Nitric Oxide. <i>Analyst</i> . 2000; 125(12):2169-2172.	

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## INFORMATION DISCLOSURE CITATION

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## APPLICANT

John D. DeNuzzio et al.

## FILING DATE

December 21, 2001

## GROUP

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	2 1 5 4 0 0 3	04/1939	Lane			
	3 2 2 4 4 3 3	12/1965	Dalebor			
	3 4 3 6 3 2 9	04/1969	Kahn et al.			
	3 8 3 8 0 3 3	09/1974	Mindt et al.			
	3 8 5 7 7 7 1	12/1974	Sternberg			
	3 9 1 2 6 1 4	10/1975	Spracklen et al.			
	3 9 4 8 7 4 5	04/1976	Guilbault et al.			
	4 0 7 1 0 2 0	01/1978	Pugliese			
	4 1 9 8 2 8 0	04/1980	Swartz			
	4 4 2 5 9 1 8	01/1984	Moll et al.			
	4 4 3 1 0 0 4	02/1984	Bessman et al.			
	4 4 3 6 0 9 4	03/1984	Cerami			
	4 4 4 0 1 7 5	04/1984	Wilkins			
	4 4 5 8 6 8 5	07/1984	Hiramoto et al.			
	4 4 5 2 2 4 9	06/1984	Sachs et al.			

## FOREIGN PATENT DOCUMENTS

DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
2 1 5 4 0 0 3	08/1985	UK			
2 1 2 0 6 5 5	05/1990	JA			
9 8 4 6 1 2 4	10/1998	PCT			

## OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, Etc.)

	Gorski et al., J. Electroanalytical Chem., "Ruthenium Catalyst for Amperometric Determination of Insulin at Physiological pH," 425 (1-2):191-199 (1997).

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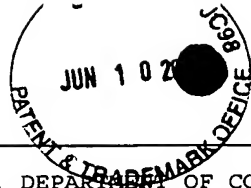
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2		4	4	5	8	6	8	6	07/1984	Clark et al.			
		4	5	3	9	9	9	4	09/1985	Baumbach et al.			
		4	5	4	5	3	8	2	10/1985	Higgins et al.			
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		4	6	2	7	4	4	5	12/1986	Garcia et al.			
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		4	9	6	0	4	6	7	10/1990	Peck			
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		4	9	9	4	1	6	7	02/1991	Shults et al.			
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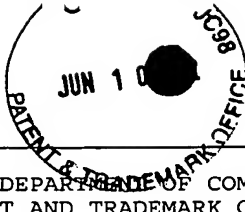
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		5	3	5	6	7	8	6	10/1994	Heller et al.			
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		5	4	1	1	5	5	1	05/1995	Winston et al.			

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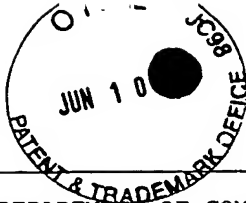
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## U.S. PATENT DOCUMENTS

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	5 4 9 7 7 7 2	03/1996	Schulman et al.			
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	5 5 6 8 8 0 6	10/1996	Cheney, II et al.			
	5 5 8 0 4 3 1	12/1996	Isaacs et al.			
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	5 5 9 3 8 5 2	01/1997	Heller et al.			
	5 6 1 7 8 5 1	04/1997	Lipkovker			
	5 6 2 8 8 9 0	05/1997	Carter et al.			
	5 6 1 1 9 0 0	03/1997	Worden et al.			
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	5 6 8 2 2 3 3	10/1997	Brinda			
	5 6 8 2 8 8 4	11/1997	Hill et al.			
	5 6 9 4 9 3 2	12/1997	Michel			
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	5 7 3 0 7 1 4	03/1998	Guy et al.			
	5 7 3 5 2 7 3	03/1998	Kurnik et al.			
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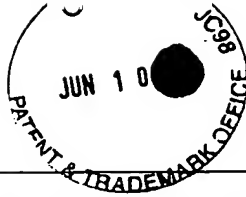
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	5 7 7 9 8 6 7	07/1998	Shieh			
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	5 7 9 8 0 3 1	08/1998	Charlton et al.			
	5 8 0 0 4 2 0	09/1998	Gross et al.			
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	5 9 1 3 8 3 3	06/1999	Elstrom et al.			
	5 9 1 6 1 5 6	06/1999	Hildenbrand et al.			
	5 9 2 5 0 2 1	07/1999	Castellano et al.			
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	5 9 5 1 4 9 2	09/1999	Douglas et al.			

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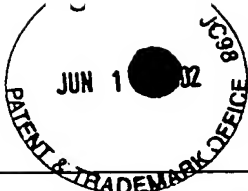
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		6	0	2	3	6	3	9	02/2000	Hakky et al.	11		
		6	0	3	0	8	2	7	02/2000	Davis et al.	11		
		6	0	3	3	8	6	6	03/2000	Guo et al.	11		
		6	0	4	8	2	3	2	04/2000	Chen	11		
		6	0	4	8	3	5	2	04/2000	Douglas et al.	11		
		6	0	5	6	7	0	1	05/2000	Duchon et al.	11		
		6	0	6	3	0	3	9	05/2000	Cunningham et al.	11		
		6	0	6	4	9	0	0	05/2000	Vadgama et al.	11		
		6	0	6	6	1	0	3	05/2000	Duchon et al.	11		
		6	0	7	1	2	4	9	06/2000	Cunningham et al.	11		
		6	0	7	1	2	9	4	06/2000	Simons et al.	11		
		6	0	7	1	3	9	1	06/2000	Gotoh et al.	11		
		6	0	7	7	6	6	0	06/2000	Wong et al.	11		

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## U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
M	6 0 8 3 7 1 0	07/2000	Heller et al.			
	6 0 9 3 1 5 6	07/2000	Cunningham et al.			
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	6 1 3 4 4 6 1	10/2000	Say et al.			
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